

Notice of References Cited	Application/Control No. 10/519,766		Applicant(s)/Patent Under Reexamination SCHULTHEIS ET AL.	
	Examiner DAVID BANH		Art Unit 2854	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,862,436 A	01-1999	Ishizawa et al.	399/69
*	B	US-6,096,443 A	08-2000	Malhotra et al.	428/690
*	C	US-2002/0088799 A1	07-2002	Behnke et al.	219/679
*	D	US-2002/0159785 A1	10-2002	Masuda et al.	399/69
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.